Serial No. 10/065,036

Docket No. 122235-1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Yudong Zhu, et al.

Serial No.: 10/065,036

Filed: September 12, 2002

For METHOD AND SYSTEM FOR EXTENDED

VOLUME IMAGING USING MRI WITH

PARALLEL RECEPTION

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Group Art Unit: 2862

Examiner: Fetzner

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

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	_	[within 3 i	months of	national, non-CPA filing or prior to 1st Office Action] n	o charge	
	∐ 2	Certific	cation F	Pursuant to 37 CFR 1.97(c)(1)		
	_	[before Fi	inal Office	Action, Allowance, or other action closing prosecution]	no charge	e
	∐ 3		•	Pursuant to 37 CFR 1.97(c)(2)	0400.00	
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	× 4			k Fee Payment Pursuant to 37 CFR 1.97	(a)	
		[On or be	fore issue	fee payment] \$180.00		
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	Sir:					
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			Service	y certify that this correspondence is being deposited with the United State as first class mail in an envelope addressed to: AssistantCommit, Washington, D.C. 20231, on the date indicated below.	ates Postal ssioner for	
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Please charge all applicable fees associated with the submittal of this Information Disclosure Statement and any other fees applicable to this application to Deposit Account No. 07-0868. An original and two (2) copies of this document are enclosed.

Respectfully submitted,

<u>フル/のサ</u> Date

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